

## GCMS020B120S1-E1



## 1200V SiC COPACK Power Module

V <sub>DS</sub>	1200 V
R <sub>DS,on</sub>	18 mΩ
I <sub>D (TC=25C)</sub>	113 A
T <sub>J</sub> ,max	175°C

#### **Features**

- High speed switching SiC MOSFETs
- Freewheeling SiC SBD with zero reverse recovery
- · Simple to drive
- · Kelvin reference for stable operation

#### **Benefits**

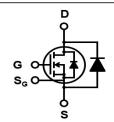
- Low switching losses
- Low junction to case thermal resistance
- · Very rugged and easy mount
- Direct mounting to heatsink (isolated package)
- Lower Q<sub>RR</sub> at high temperature

#### **Applications**

- Photovoltaic Inverter
- · Battery charger
- Server power supplies
- · Energy storage system

#### **Package**





- (1) S<sub>G</sub> (Driver Source)
- (2) G (Gate)
- (3) D (Drain)
- (4) S (Source)

Part #	Package	Marking
GCMS020B120S1-E1	SOT-227	GCMS020B120S1-E1



#### **Absolute Maximum Ratings**

Characteristics	Symbol	Conditions	Values	Unit	
Drain-Source Voltage	$V_{rated}$	$V_{GS}$ =0V, $I_D$ =200 $\mu$ A	1200	V	
	1	T <sub>C</sub> =25°C, V <sub>GS</sub> =20V	113		
Continuous Drain Current	I <sub>DS</sub>	T <sub>C</sub> =100°C, V <sub>GS</sub> =20V	81		
	I <sub>SD</sub> *	T <sub>C</sub> =25°C, V <sub>GS</sub> =20V	143	Α	
Schottky Diode DC Current	I <sub>F</sub>	T <sub>C</sub> =25°C, V <sub>GS</sub> =-5V	106		
Pulsed Drain Current	I <sub>DS,pulse</sub> **	T <sub>C</sub> =25°C, V <sub>GS</sub> =20V	250		
Gate Source Voltage	$V_{GSmax}$		-10/25	V	
Gale Source Vollage	$V_{GSop}$	Recommended operational	-5/20	V	
Power Dissipation - MOSFET	P <sub>tot</sub>	T <sub>C</sub> =25°C	395	W	
Operating & Storage Temperature	T <sub>J</sub> , T <sub>storage</sub>	Continuous	-55175	°C	

 $<sup>{}^*{\</sup>rm I}_{\rm SD}$  maximum continous current for parallel SBD and MOSFET body diode assuming maximum Rth $_{\rm JC}$  of SBD

<sup>\*\*</sup>Pulse width is limited by T<sub>Jmax</sub>

# GCMS020B120S1-E1

## Static Electrical Characteristics, at T<sub>J</sub>=25°C, unless otherwise specified

Characteristics	Symbol Conditions —		Values			Unit
Cildiacteristics			min.	typ.	max.	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =1mA	1200	-	-	V
Zero Gate Voltage Drain Current	ı	V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V	-	5	100	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =175°C	-	159	750	μA
Cata Sauraa Laakaga Current	I <sub>GSS+</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	-	10	1000	nA
Gate-Source Leakage Current	I <sub>GSS-</sub>	V <sub>GS</sub> =-5V, V <sub>DS</sub> =0V	-	-10	-1000	I IIA
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS}=V_{DS}$ , $I_{D}=20$ mA	1.8	2.8	4	V
Gate Tilleshold Voltage		$V_{GS}=V_{DS}$ , $I_D=20$ mA, $T_J=175$ °C	-	1.7	-	
	R <sub>DSon</sub>	V <sub>GS</sub> =20V, I <sub>D</sub> =50A	-	18.1	28	- mΩ
Drain-Source On-Resistance		V <sub>GS</sub> =20V, I <sub>D</sub> =25A	-	17.6	26	
Diani-Source On-Resistance		V <sub>GS</sub> =20V, I <sub>D</sub> =50A, T <sub>J</sub> =125°C	-	24	-	
		V <sub>GS</sub> =20V, I <sub>D</sub> =50A, T <sub>J</sub> =175°C	-	30	-	
Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =20V, I <sub>D</sub> =50A	-	25	-	S
Internal Gate Resistance	$R_{G(int)}$	f=1MHz, V <sub>AC</sub> =25mV, D-S Short	-	0.8	-	Ω

## AC Electrical Characteristics, at T<sub>J</sub>=25°C, unless otherwise specified

Characteristics	Cumbal	Conditions	Values			Unit
Cital acteristics	Symbol Conditions	min.	typ.	max.	Unit	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> =0V	-	5279	-	
Output Capacitance	C <sub>OSS</sub> **	V <sub>DS</sub> =1000V	-	436	-	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>	f=200kHz	-	19	-	
Coss Stored Energy	E <sub>oss</sub> ***	V <sub>AC</sub> =25mV	-	265	-	μJ
Turn-On Switching Energy	E <sub>ON</sub>		-	0.57	-	mJ
Turn-Off Switching Energy	E <sub>OFF</sub>	$V_{DD}$ =800V, $I_{DS}$ =50A, $R_{G(ext)}$ =3.9 $\Omega$ ,	-	0.27	-	1113
Turn-On Delay Time	t <sub>D(on)</sub>	V <sub>GS</sub> =-5/+20V, L=273μH,	-	25	-	
Rise Time	t <sub>R</sub>	FWD=GCMS020B120S1-E1	-	8	-	1
Turn-Off Delay Time	t <sub>D(off)</sub>	1	-	46	-	ns
Fall Time	t <sub>F</sub>	1	-	25	-	
Total Gate Charge	$Q_{G}$	V -000V I -50A	-	215	-	
Gate to Source Charge	$Q_{GS}$	-V <sub>DD</sub> =800V, I <sub>DS</sub> =50A -V <sub>GS</sub> =-5/20V	-	76	-	nC
Gate to Drain Charge	$Q_{GD}$	7 V GS0/20 V	-	43	-	

<sup>\*\*</sup> $C_{OSS}$  is combination of MOSFET  $C_{OSS}$  and diode junction capacitance

# Freewheeling Diode Characteristics, at T<sub>J</sub>=25°C, unless otherwise specified

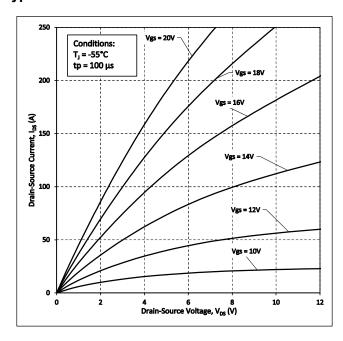
Characteristics	Symbol Conditions		Values			Unit
Characteristics	Symbol	min.	typ.	max.	Oilit	
Diode Forward Voltage	V	V <sub>GS</sub> =-5V, I <sub>S</sub> =50A	-	1.49	1.7	V
	$V_{SD}$	V <sub>GS</sub> =-5V, I <sub>S</sub> =50A, T <sub>J</sub> =175°C	-	2.13	-	,
Reverse Recovery Time	t <sub>RR</sub>		-	19	-	ns
Reverse Recovery Charge		I <sub>S</sub> =50A, V <sub>R</sub> =800V, V <sub>GS</sub> =-5V	-	805	-	nC
Peak Reverse Recovery Current		di/dt=8.3A/ns	-	70	-	Α
Reverse Recovery Energy	E <sub>RR</sub>		-	0.49	-	mJ

<sup>\*\*\*</sup> $E_{\mbox{\scriptsize OSS}}$  is calculated from  $C_{\mbox{\scriptsize OSS}}$  curve

# Thermal and Package Characteristics, at $T_j$ =25 °C, unless otherwise specified

Characteristics	Symbol Conditions	Values			Unit	
Cital acteristics		min.	typ.	max.	Oilit	
Thermal resistance, junction-case	R <sub>thJC</sub>	MOSFET only	-	0.31	0.38	°C/W
Thermal resistance, junction-case	R <sub>thJC</sub>	Schottky diode only	-	0.38	0.46	C/VV
Mounting torque	M <sub>d</sub>	M4-0.7 screws	1.1	-	1.5	N-m
Terminal connection torque	M <sub>dt</sub>	M4-0.7 screws	-	1.1	1.3	IN-III
Package weight	W <sub>t</sub>		-	32	-	g
Isolation voltage	V <sub>ISOL</sub>	I <sub>ISOL</sub> < 1mA, 50/60 Hz, 2 s	4000	-	-	V

## **Typical Performance**



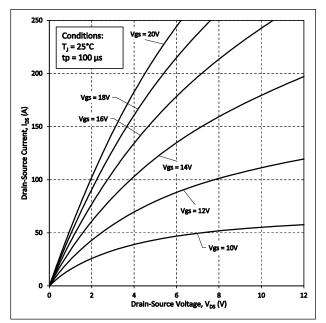
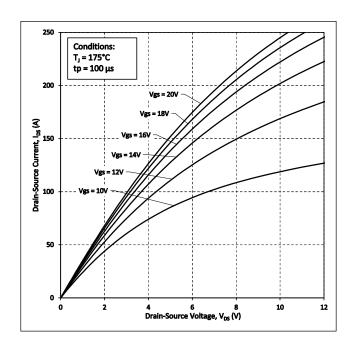


Figure 1. Output Characteristics  $T_J = -55^{\circ}C$ 

Figure 2. Output Characteristics  $T_J = 25^{\circ}C$ 



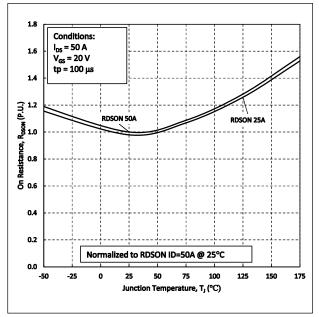
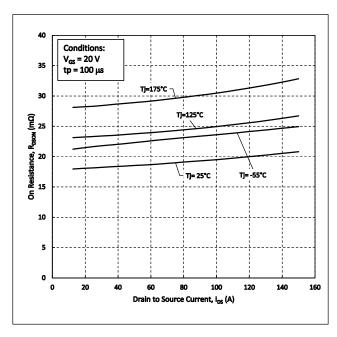
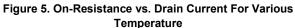


Figure 3. Output Characteristics T<sub>J</sub> = 175°C

Figure 4. Normalized On-Resistance vs. Temperature





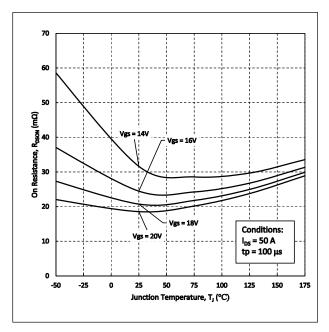


Figure 6. On-Resistance vs. Temperature For Various Gate Voltages

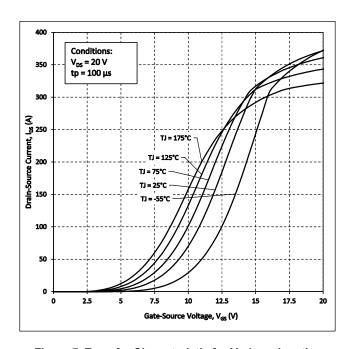


Figure 7. Transfer Characteristic for Various Junction Temperatures

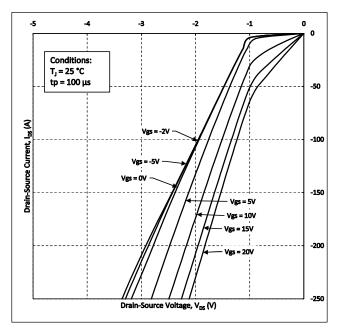


Figure 9. Freewheeling Diode Characteristics at  $T_J = 25^{\circ}\text{C}$ 

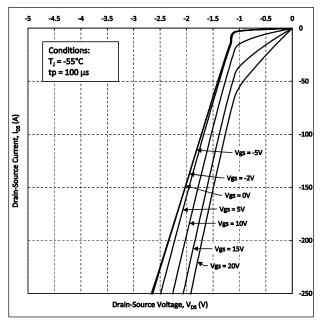


Figure 8. Freewheeling Diode Characteristics at  $T_J = -55^{\circ}\text{C}$ 

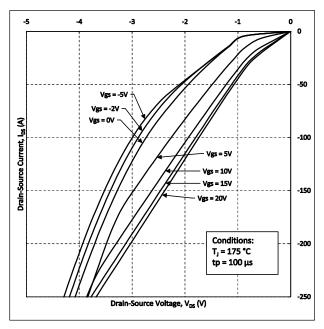
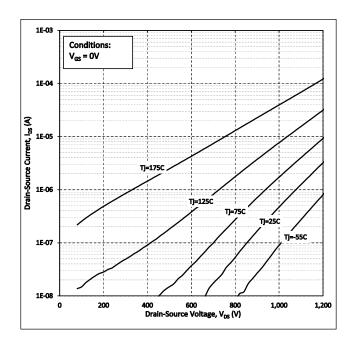


Figure 10. Freewheeling Diode Characteristics at  $T_J$  = 175°C



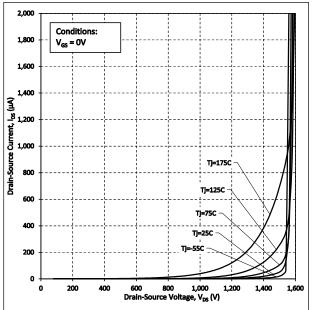
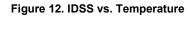
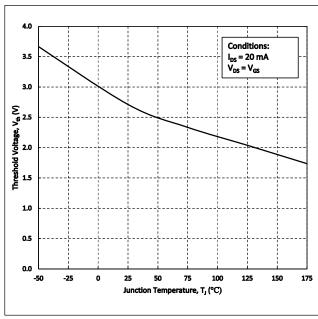
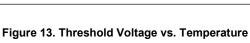


Figure 11. IDSS vs. Temperature







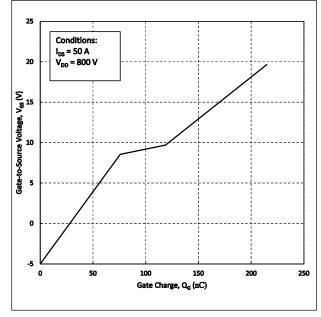
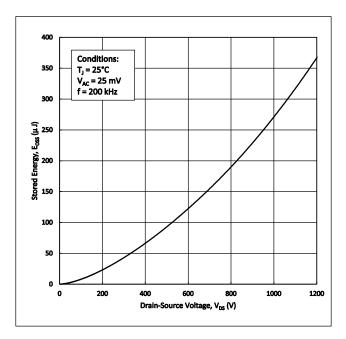


Figure 14. Gate Charge Characteristics



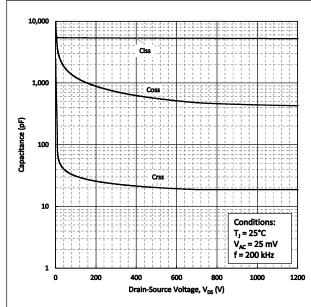


Figure 15. Output Capacitor Stored Energy

Figure 16. Capacitance vs Drain-Source Voltage

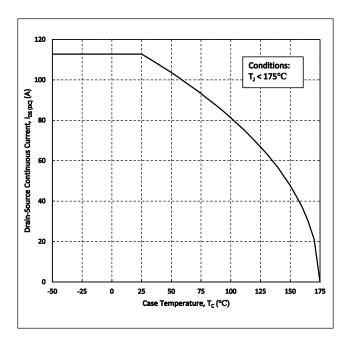


Figure 17. Continuous Drain Current Derating vs. Case Temperature

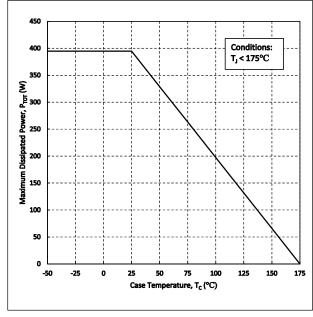


Figure 18. Maximum Power Dissipation Derating vs
Case Temperature

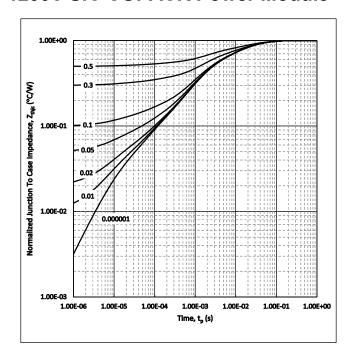


Figure 19. Transient Thermal impedance (Junction to Case)

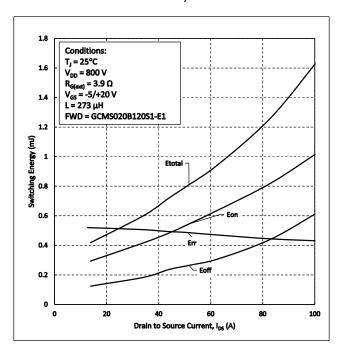


Figure 21. Clamped Inductive Switching Energy vs. Drain
Current

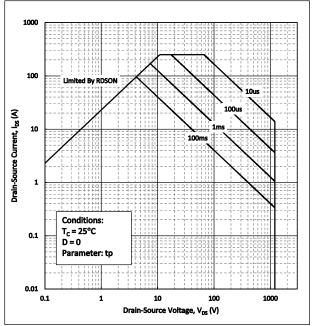


Figure 20. Safe Operating Area

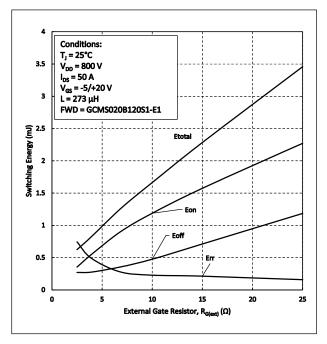
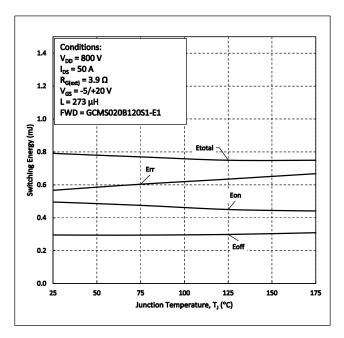


Figure 22. Clamped Inductive Switching Energy vs.  $R_{\text{G(ext)}} \label{eq:RG(ext)}$ 



200 Conditions:

T<sub>1</sub> = 25°C

V<sub>DD</sub> = 800 V

I<sub>DS</sub> = 50A

L = 273 μH

V<sub>GS</sub> = -5/+20 V

150

50

External Gate Resistor, R<sub>G(ext)</sub> (Ω)

Figure 23. Clamped Inductive Switching Energy vs.
Temperature

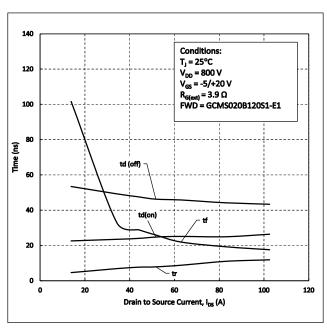


Figure 24. Switching Times vs  $R_{G(ext)}$ 

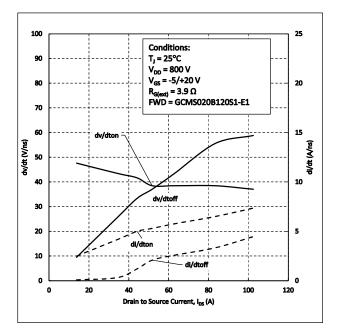
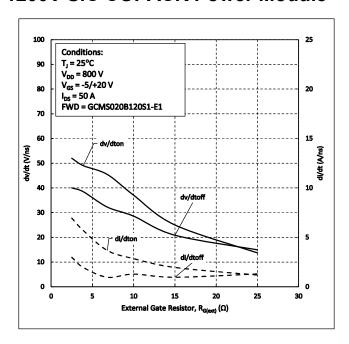


Figure 25. Switching Times vs. Drain Current

Figure 26. dv/dt and di/dt vs. Drain Current



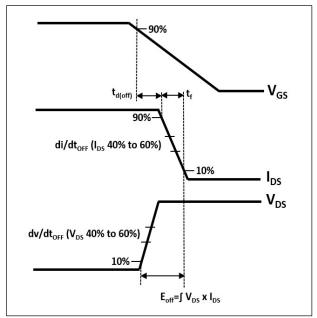


Figure 27. dv/dt and di/dt vs.  $R_{\text{G(ext)}}$ 

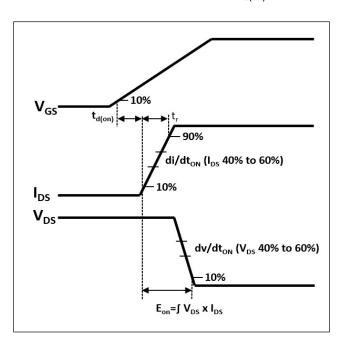


Figure 29. Turn-on Transient Definitions

Figure 28. Turn-off Transient Definitions

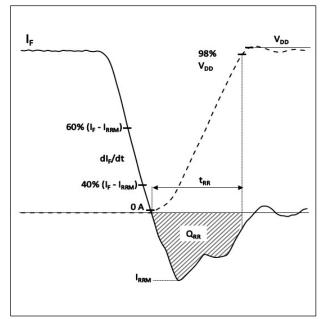
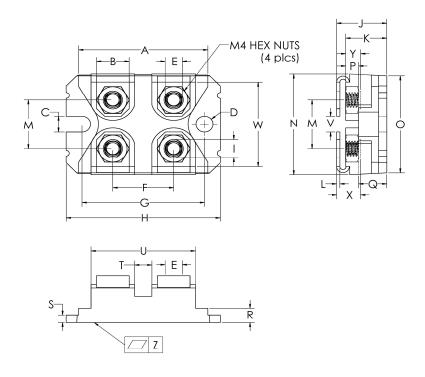


Figure 30. Reverse Recovery Definitions

# **Package Dimensions SOT-227**



Sym	Millin	neters	Inc	hes
Sym	Min	Max	Min	Max
Α	31.67	31.90	1.247	1.256
В	7.95	8.18	0.313	0.322
С	4.14	4.24	0.163	0.167
D	4.14	4.24	0.163	0.167
E	4.14	4.24	0.163	0.167
F	14.94	15.09	0.588	0.594
G	30.15	30.25	1.187	1.191
Н	38.00	38.10	1.496	1.500
I	4.75	4.83	0.187	0.190
J	11.68	12.19	0.460	0.480
K	9.45	9.60	0.372	0.378
L	0.76	0.84	0.030	0.033
M	12.62	12.88	0.497	0.507
N	25.15	25.30	0.990	0.996
0	24.79	25.04	0.976	0.986
Р	3.02	3.15	0.119	0.124
Q	6.71	6.96	0.264	0.274
R	4.17	4.42	0.164	0.174
S	2.08	2.13	0.082	0.084
Т	3.28	3.63	0.129	0.143
U	26.75	26.90	1.053	1.059
V	3.86	4.24	0.152	0.167
W	20.55	26.90	0.809	0.814
Х	5.45	5.85	0.215	0.230
Υ	3.15	3.66	0.124	0.144
Z	0.00	0.13	0.000	0.005

#### GCMS020B120S1-E1

Revision History				
Date	Revision	Notes		
4/29/2022	0.1	Preliminary release		
9/28/2022	0.2	Updated switching test data		
8/4/2023	1.0	Initial Release		

#### <u>Notes</u>

#### **RoHS Compliance**

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented March, 2013. RoHS Declarations for this product can be obtained from the Product Documentation sections of www.SemiQ.com.

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